

# **RF Exposure Report**

Report No.: SA140704E05D

FCC ID: MQT-E25CMFI

Test Model: xCE-25-C

Series Model: xCE\_E25C

Received Date: Jan. 10, 2017

Test Date: Jan. 19, 2017

**Issued Date:** Feb. 06, 2017

Applicant: XAC AUTOMATION CORP.

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### **Release Control Record**

Issue No.	Description	Date Issued
SA140704E05D	Original release.	Feb. 06, 2017

Page No. 3 / 6 Report Format Version: 6.1.1

Report No.: SA140704E05D Reference No.: 170110E10



### 1 Certificate of Conformity

Product: PINPAD

Brand: XAC

Test Model: xCE-25-C

Series Model: xCE\_E25C

Sample Status: ENGINEERING SAMPLE

Applicant: XAC AUTOMATION CORP.

Test Date: Jan. 19, 2017

Standards: FCC Part 2 (Section 2.1093)

KDB 447498 D01 General RF Exposure Guidance v06

IEEE C95.1-1992

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Midoli Peng / Specialist

**Approved by:** , **Date:** Feb. 06, 2017

May Chen / Manager



#### 2 Evaluation Result

Following FCC KDB 447498 D01 "General SAR test exclusion guidance"

The corresponding SAR Exclusion Threshold condition, listed below:

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)]  $\cdot [\sqrt{f(GHz)}] \le 3.0$  for 1-g SAR and  $\le 7.5$  for 10-g extremity SAR, where

- f(GHz) is the RF channel transmit frequency in GHz.
- Power and distance are rounded to the nearest mW and mm before calculation.
- ➤ The result is rounded to one decimal place for comparison The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.</p>
- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
  - a) [Threshold at 50 mm in step 1) + (test separation distance 50mm)·( f(MHz)/150)] mW, at 100MHz to 1500 MHz
  - b) [Threshold at 50 mm in step 1) + (test separation distance 50 mm)·10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
  - a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by [1 + log(100/f(MHz))] for test separation distances > 50 mm and < 200 mm.</li>
  - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by  $\frac{1}{2}$  for test separation distances  $\leq$  50 mm.
  - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.



#### 3 SAR Test Exclusion Thresholds

Maximum measured transmitter power:

#### For BT-EDR

. 6. 5. 5.1						
Frequency (GHz)	Max. Power (mW)	Min. test separation distance (mm)	SAR test exclusion calculation value <sup>(NOTE 2)</sup>	10-g extremity SAR test exclusion thresholds	Result	
2.402 ~ 2.480	0.4645	5	0.14629907	7.5	Pass	

**NOTE:** 1. The antenna type is Chip antenna with 1.5dBi gain.

2. Calculate SAR test exclusion thresholds from condition "1" formulas.

#### For BT-LE

Frequency (GHz)	Max. Power (mW)	Min. test separation distance (mm)	SAR test exclusion calculation value <sup>(NOTE 2)</sup>	10-g extremity SAR test exclusion thresholds	Result
2.402 ~ 2.480	0.4667	5	0.14699198	7.5	Pass

NOTE: 1. The antenna type is Chip antenna with 1.5dBi gain.

2. Calculate SAR test exclusion thresholds from condition "1" formulas.

#### **For RFID**

Freq. (MHz)	Electric field (dBuV/m)@3m	Pout EIRP (dBm)	Pout EIRP (mW)	Min. test separation distance (mm)	SAR test exclusion thresholds	Pass /Fail
13.56	69.3	-25.93	0.0026	≤ 50	442.9735	Pass

**NOTE:** Pout EIRP (dBm) = Field Strength of Fundamental (dBuV/m) - 95.23 (dB)

### 4 Conclusion

Since Source-base time average power is below SAR test exclusion power thresholds, the SAR evaluation is not required.

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